



Validation and Measurement in Analytical Chemistry: Practical Aspects

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Deadline for manuscript
submissions:

30 September 2024

Message from the Guest Editor

This Special Issue is aimed at covering the recent progress and practical aspects of validation and verification of analytical methods and quality control of measurements in analytical chemistry. It is envisaged to gether original high-quality papers and comprehensive reviews.

Applied aspects of validation and quality control procedures together with their advantages, limitations and interpretation of the results are especially encouraged. Reports on specific samples, analytes or analytical methods in different fields of science and technology are of interest. Examples of application of validated analytical methods will be also considered, especially if they present how a given issue or specific limitations are addressed. Comprehensive reviews presenting the current achievements and trends in validation of analytical methods and quality control of measurements in analytical chemistry are also invited.





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Message from the Editor-in-Chief

As the world of science becomes ever more specialized, researchers may lose themselves in the deep forest of the ever increasing number of subfields being created. This open access journal Applied Sciences has been started to link these subfields, so researchers can cut through the forest and see the surrounding, or quite distant fields and subfields to help develop his/her own research even further with the aid of this multi-dimensional network.

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